TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOS IV)

TPCF8302

TENTATIVE

Notebook PC Applications Portable Equipment Applications

• Low drain-source ON resistance: RDS (ON) = 44 mÙ (typ.)

• High forward transfer admittance: $|Y_{fs}| = 6.2 \text{ S (typ.)}$

• Low leakage current: IDSS = 10 iA (max) (VDS = 20 V)

• Enhancement-model: $V_{th} = 0.5 \text{ to} 1.2 \text{ V}$

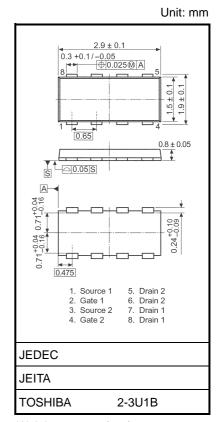
 $(V_{DS} = 10 \text{ V}, I_{D} = 200 \text{ iA})$

Maximum Ratings (Ta = 25°C)

Cha	racteristics	Symbol	mbol Rating		
Drain-source voltage	ge	V_{DSS}	-20	V	
Drain-gate voltage	$(R_{GS} = 20 \text{ k}\Omega)$	V_{DGR}	-20	V	
Gate-source voltage	je	V _{GSS}	±10	V	
Drain current	DC (Note 1)	I _D	-3.0	Α	
Diaili Current	Pulse (Note 1)	I _{DP}	-12	^	
Drain power	Single-device operation (Note 3a)	P _{D (1)}	1.35		
dissipation (t = 5 s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _{D (2)}	1.12	W	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	0.53	VV	
(t = 5 s) (Note 2b)	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.33		
Single pulse avalar	nche energy (Note 4)	E _{AS}	0.58	mJ	
Avalanche current		I _{AR}	-1.5	Α	
Repetitive avalance Single-device value	E _{AR}	0.11	mJ		
Channel temperatu	el temperature T _{ch} 150			°C	
Storage temperatu	re range	T _{stg}	-55~150 °€		

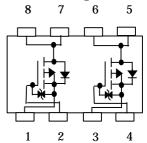
Note: For (Note 1), (Note 2), (Note 3), (Note 4), (Note 5) and (Note 6), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.

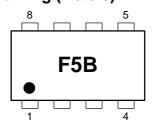


Weight: 0.011 g (typ.)

Circuit Configuration



Marking (Note 6)



Thermal Characteristics

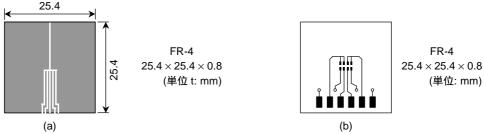
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Characteristics		Symbol	Max	Unit	
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	92.6	°C/W	
(t = 5 s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	111.6	C/ VV	
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	235.8	°C/W	
(t = 5 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	378.8	C/ VV	

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (b) Device mounted on a glass-epoxy board (b)

Note 3: a) The power dissipation and thermal resistance values are shown for a single device



(During single-device operation, power is only applied to one device.).

b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

Note 4: $V_{DD} = -16 \text{ V}$, $T_{Ch} = 25^{\circ}\text{C}$ (initial), L = 0.5 mH, $R_G = 25 \Omega$, $I_{AR} = -1.5 \text{ A}$

Note 5: Repetitive rating; Pulse width limited by Max. Channel temperature.

Note 6: Black round marking " "locates on the left lower side of parts number marking "F5B" indicates terminal No. 1.

Electrical Characteristics (Ta = 25°C)

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Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 10V, V_{DS} = 0 V$	_	_	±10	μΑ	
Drain cut-off curr	ent	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	-10	μΑ	
Drain course bro	akdown voltago	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-20	_	_	V	
Dialii-source bre	akdown voltage	V (BR) DSX	$I_D = -10$ mA, $V_{GS} = 10$ V	-10 — —		_]	
Gate threshold ve	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -200 \mu\text{A}$	-0.5	_	-1.2	V	
		R _{DS (ON)}	$V_{GS} = -2.0 \text{ V}, I_D = -1.5 \text{ A}$	_	100	200		
Drain-source ON	resistance	R _{DS} (ON)	$V_{GS} = -2.5 \text{ V}, I_D = -1.5 \text{ A}$	_	68	95	mΩ	
		R _{DS} (ON)	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$	_	44	59	.	
Forward transfer	admittance	Y _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -1.5 \text{ A}$	3.1 6.2 —		_	S	
Input capacitance		C _{iss}		_	800	_		
Reverse transfer	capacitance	C _{rss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	120	_	pF	
Output capacitance		C _{oss}		_	160	_		
	Rise time	t _r	, 0 V ¬ Γ I _D = −1.5 A	_	6.2	_		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	15	_						
	Fall time	t _f	4.7Ω M. M. M	_	17	_	ns	
	Turn-off time	t _{off}	55	_	51	_		
0	te-source plus gate-drain)			11	_			
Gate-source charge1		Q _{gs1}	7 00	_	1.1	_	nC	
Gate-drain ("miller") charge		Q_{gd}]	_	3.3	_		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characterist	ics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	-12	Α
Forward voltage (diode)		V _{DSF}	$I_{DR} = -3.0 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	1.2	V

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